Intel - <u>5AGZME1E2H29C3N Datasheet</u>





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Understanding <u>Embedded - FPGAs (Field</u> <u>Programmable Gate Array)</u>

Embedded - FPGAs, or Field Programmable Gate Arrays, are advanced integrated circuits that offer unparalleled flexibility and performance for digital systems. Unlike traditional fixed-function logic devices, FPGAs can be programmed and reprogrammed to execute a wide array of logical operations, enabling customized functionality tailored to specific applications. This reprogrammability allows developers to iterate designs quickly and implement complex functions without the need for custom hardware.

Applications of Embedded - FPGAs

The versatility of Embedded - FPGAs makes them indispensable in numerous fields. In telecommunications.

Details

Details	
Product Status	Obsolete
Number of LABs/CLBs	10377
Number of Logic Elements/Cells	220000
Total RAM Bits	15282176
Number of I/O	342
Number of Gates	-
Voltage - Supply	0.82V ~ 0.88V
Mounting Type	Surface Mount
Operating Temperature	0°C ~ 85°C (TJ)
Package / Case	780-BBGA, FCBGA
Supplier Device Package	780-HBGA (33x33)
Purchase URL	https://www.e-xfl.com/product-detail/intel/5agzme1e2h29c3n

Email: info@E-XFL.COM

Address: Room A, 16/F, Full Win Commercial Centre, 573 Nathan Road, Mongkok, Hong Kong

Caution: Conditions outside the range listed in the following table may cause permanent damage to the device. Additionally, device operation at the absolute maximum ratings for extended periods of time may have adverse effects on the device.

Table 1-1: Absolute Maximum Ratings for Arria V Devices

Symbol	Description	Minimum	Maximum	Unit
V _{CC}	Core voltage power supply	-0.50	1.43	V
V _{CCP}	Periphery circuitry, PCIe [®] hardIP block, and transceiver physical coding sublayer (PCS) power supply	-0.50	1.43	V
V _{CCPGM}	Configuration pins power supply	-0.50	3.90	V
V _{CC_AUX}	Auxiliary supply	-0.50	3.25	V
V _{CCBAT}	Battery back-up power supply for design security volatile key register	-0.50	3.90	V
V _{CCPD}	I/O pre-driver power supply	-0.50	3.90	V
V _{CCIO}	I/O power supply	-0.50	3.90	V
V _{CCD_FPLL}	Phase-locked loop (PLL) digital power supply	-0.50	1.80	V
V _{CCA_FPLL}	PLL analog power supply	-0.50	3.25	V
V _{CCA_GXB}	Transceiver high voltage power	-0.50	3.25	V
V _{CCH_GXB}	Transmitter output buffer power	-0.50	1.80	V
V _{CCR_GXB}	Receiver power	-0.50	1.50	V
V _{CCT_GXB}	Transmitter power	-0.50	1.50	V
V _{CCL_GXB}	Transceiver clock network power	-0.50	1.50	V
VI	DC input voltage	-0.50	3.80	V
V _{CC_HPS}	HPS core voltage and periphery circuitry power supply	-0.50	1.43	V
V _{CCPD_HPS}	HPS I/O pre-driver power supply	-0.50	3.90	V
V _{CCIO_HPS}	HPS I/O power supply	-0.50	3.90	V
V _{CCRSTCLK_HPS}	HPS reset and clock input pins power supply	-0.50	3.90	V



1-4 Recommended Operating Conditions

Symbol	Description	Condition (V)	Overshoot Duration as % of High Time	Unit
		3.8	100	%
		3.85	68	%
		3.9	45	%
		3.95	28	%
		4	15	%
		4.05	13	%
		4.1	11	%
		4.15	9	%
Vi (AC)	AC input voltage	4.2	8	%
		4.25	7	%
		4.3	5.4	%
		4.35	3.2	%
		4.4	1.9	%
		4.45	1.1	%
		4.5	0.6	%
		4.55	0.4	%
		4.6	0.2	%

Recommended Operating Conditions

This section lists the functional operation limits for the AC and DC parameters for Arria V devices.

Recommended Operating Conditions

Table 1-3: Recommended Operating Conditions for Arria V Devices

This table lists the steady-state voltage values expected from Arria V devices. Power supply ramps must all be strictly monotonic, without plateaus.



I/O Standard		V _{CCIO} (V)		V _{SW}	$V_{SWING(DC)}(V)$ $V_{X(AC)}(V)$ $V_{SWING(AC)}$		V _{X(AC)} (V)		_{WING(AC)} (V)	
	Min	Тур	Max	Min	Мах	Min	Тур	Мах	Min	Max
SSTL-125	1.19	1.25	1.31	0.18	(15)	V _{CCIO} /2 – 0.15	V _{CCIO} /2	V _{CCIO} /2 + 0.15	2(V _{IH(AC)} – V _{REF})	$2(V_{IL(AC)} - V_{REF})$

Differential HSTL and HSUL I/O Standards

Table 1-18: Differential HSTL and HSUL I/O Standards for Arria V Devices

I/O Standard)	$V_{\text{DIF}(\text{DC})}(V)$ $V_{X(\text{AC})}(V)$		V _{CM(DC)} (V)			V _{DIF(AC)} (V)					
	Min	Тур	Max	Min	Max	Min	Тур	Max	Min	Тур	Max	Min	Max
HSTL-18 Class I, II	1.71	1.8	1.89	0.2	_	0.78	—	1.12	0.78		1.12	0.4	
HSTL-15 Class I, II	1.425	1.5	1.575	0.2	_	0.68	—	0.9	0.68		0.9	0.4	
HSTL-12 Class I, II	1.14	1.2	1.26	0.16	V _{CCIO} + 0.3		$0.5 \times V_{ m CCIO}$	_	$0.4 \times V_{ m CCIO}$	$0.5 \times V_{ m CCIO}$	$0.6 \times V_{ m CCIO}$	0.3	V _{CCIO} + 0.48
HSUL-12	1.14	1.2	1.3	0.26	0.26	$\begin{array}{c} 0.5 \times \\ V_{\rm CCIO} - \\ 0.12 \end{array}$	$0.5 imes V_{ m CCIO}$	$0.5 \times V_{CCIO} + 0.12$	$0.4 \times V_{\rm CCIO}$	$0.5 \times V_{ m CCIO}$	0.6 × V _{CCIO}	0.44	0.44

Differential I/O Standard Specifications

Table 1-19: Differential I/O Standard Specifications for Arria V Devices

Differential inputs are powered by V_{CCPD} which requires 2.5 V.



Symbol/Description	Condition -	Transceiver Speed Grade 4			Transceiver Speed Grade 6			Unit
		Min	Тур	Max	Min	Тур	Max	Onit
Inter-transceiver block transmitter channel-to- channel skew ⁽³⁹⁾	×N PMA bonded mode	_	_	500	_	_	500	ps

Table 1-24: CMU PLL Specifications for Arria V GX and SX Devices

Symbol/Description	Transceiver S	peed Grade 4	Transceiver S	peed Grade 6	Unit	
Symbol/Description	Min	Мах	Min	Мах	Onit	
Supported data range	611	6553.6	611	3125	Mbps	
fPLL supported data range	611	3125	611	3125	Mbps	

Table 1-25: Transceiver-FPGA Fabric Interface Specifications for Arria V GX and SX Devices

Symbol/Description	Transceiver Spee	ed Grade 4 and 6	Unit
Symbol/Description	Min	Мах	Unit
Interface speed (single-width mode)	25	187.5	MHz
Interface speed (double-width mode)	25	163.84	MHz

Related Information

- CTLE Response at Data Rates > 3.25 Gbps across Supported AC Gain and DC Gain on page 1-35
- CTLE Response at Data Rates \leq 3.25 Gbps across Supported AC Gain and DC Gain on page 1-36
- Arria V GT, GX, ST, and SX Device Family Pin Connection Guidelines Provides more information about the power supply connection for different data rates.



⁽³⁹⁾ This specification is only applicable to channels on one side of the device across two transceiver banks.

Symbol/Description	Condition -	Tran	sceiver Speed Gra	Unit	
Symbol/Description	Condition	Min	Тур	Max	Ont
	10 Hz	—	—	-50	dBc/Hz
	100 Hz			-80	dBc/Hz
Transmitter REFCLK phase noise ⁽⁴³⁾	1 KHz		—	-110	dBc/Hz
Hansmitter REFCLK phase hoise	10 KHz			-120	dBc/Hz
	100 KHz	—	—	-120	dBc/Hz
	≥1 MHz			-130	dBc/Hz
R _{REF}		—	2000 ±1%	—	Ω

Table 1-27: Transceiver Clocks Specifications for Arria V GT and ST Devices

Symbol/Description	Condition	Tran	sceiver Speed Gra	Unit		
Symbol/Description	Condition	Min	Тур	Max	Ont	
fixedclk clock frequency	PCIe Receiver Detect	_	125	_	MHz	
Transceiver Reconfiguration Controller IP (mgmt_clk_clk) clock frequency	—	75	—	125	MHz	

Table 1-28: Receiver Specifications for Arria V GT and ST Devices

Symbol/Description	Condition	Т	ransceiver Speed Gra	Unit		
	Condition	Min	Тур	Max	Onit	
Supported I/O Standards	1.5 V PCML, 2.5 V PCML, LVPECL, and LVDS					
Data rate (6-Gbps transceiver) ⁽⁴⁴⁾	—	611	—	6553.6	Mbps	

⁽⁴³⁾ The transmitter REFCLK phase jitter is 30 ps p-p (5 ps RMS) with bit error rate (BER) 10⁻¹², equivalent to 14 sigma.

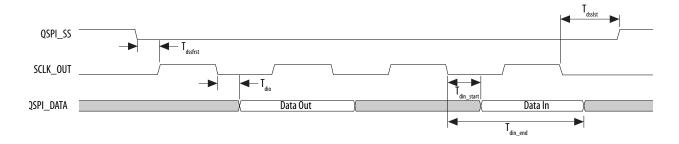


⁽⁴⁴⁾ To support data rates lower than the minimum specification through oversampling, use the CDR in LTR mode only.

Symbol	Description	Min	Тур	Max	Unit
T _{din_end}	Input data valid end	$(2 + R_{delay}) \times T_{qspi_clk} - 1.21^{(85)}$		_	ns

Figure 1-8: Quad SPI Flash Timing Diagram

This timing diagram illustrates clock polarity mode 0 and clock phase mode 0.



Related Information

Quad SPI Flash Controller Chapter, Arria V Hard Processor System Technical Reference Manual

Provides more information about Rdelay.

SPI Timing Characteristics

Table 1-52: SPI Master Timing Requirements for Arria V Devices

The setup and hold times can be used for Texas Instruments SSP mode and National Semiconductor Microwire mode.

Symbol	Description	Min	Max	Unit
T _{clk}	CLK clock period	16.67	_	ns
T _{su}	SPI Master-in slave-out (MISO) setup time	8.35 (86)	_	ns

 $^{^{(85)}}$ R_{delay} is set by programming the register <code>qspiregs.rddatacap</code>. For the SoC EDS software version 13.1 and later, Altera provides automatic Quad SPI calibration in the preloader. For more information about R_{delay}, refer to the Quad SPI Flash Controller chapter in the Arria V Hard Processor System Technical Reference Manual.



After the Boot ROM code exits and control is passed to the preloader, software can adjust the value of drvsel and smplsel via the system manager. drvsel can be set from 1 to 7 and smplsel can be set from 0 to 7. While the preloader is executing, the values for SDMMC_CLK and SDMMC_CLK_OUT increase to a maximum of 200 MHz and 50 MHz respectively.

The SD/MMC interface calibration support will be available in a future release of the preloader through the SoC EDS software update.

Symbol	Description	Min	Мах	Unit
	SDMMC_CLK clock period (Identification mode)	20	_	ns
T _{sdmmc_clk} (internal reference clock)	SDMMC_CLK clock period (Default speed mode)	5	_	ns
	SDMMC_CLK clock period (High speed mode)	5	_	ns
	SDMMC_CLK_OUT clock period (Identification mode)	2500	_	ns
T _{sdmmc_clk_out} (interface output clock)	SDMMC_CLK_OUT clock period (Default speed mode)	40	_	ns
	SDMMC_CLK_OUT clock period (High speed mode)	20	_	ns
T _{dutycycle}	SDMMC_CLK_OUT duty cycle	45	55	%
T _d	SDMMC_CMD/SDMMC_D output delay	$\frac{(T_{sdmmc_clk} \times drvsel)/2}{-1.23^{(87)}}$	$\begin{array}{c} (\mathrm{T}_{sdmmc_clk} \times \texttt{drvsel})/2 \\ + 1.69^{\ (87)} \end{array}$	ns
T _{su}	Input setup time	$1.05 - (T_{sdmmc_clk} \times smplsel)/2^{(88)}$		ns
T _h	Input hold time	$\frac{(T_{sdmmc_clk} \times \texttt{smplsel})}{2^{(88)}}$	—	ns



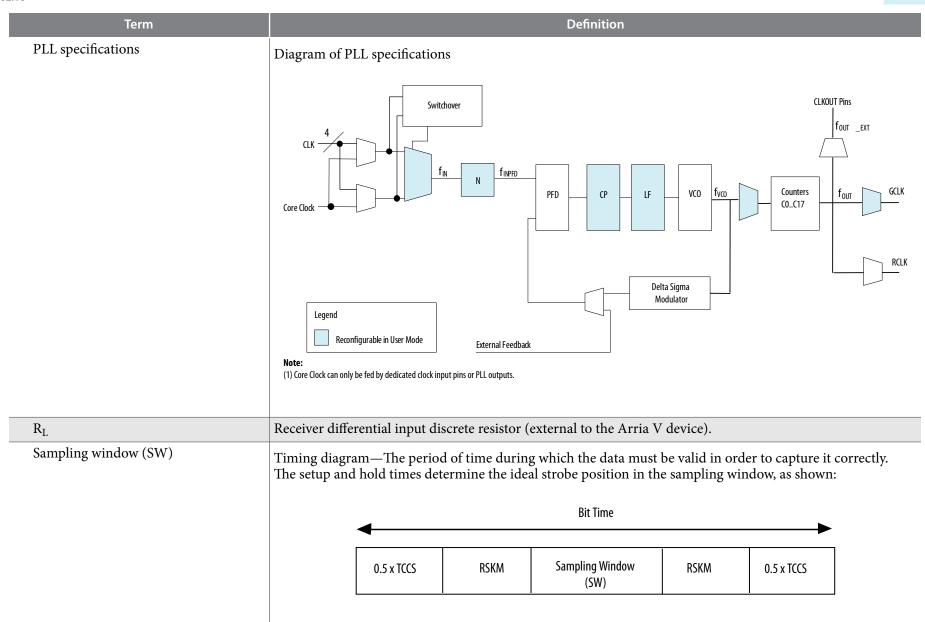
⁽⁸⁷⁾ drvsel is the drive clock phase shift select value.

⁽⁸⁸⁾ smplsel is the sample clock phase shift select value.

			Active Seria	 (108)	Fast Passive Parallel ⁽¹⁰⁹⁾			
Variant	Member Code	Width	DCLK (MHz)	Minimum Configura- tion Time (ms)	Width	DCLK (MHz)	Minimum Configuration Time (ms)	
	A1	4	100	178	16	125	36	
	A3	4	100	178	16	125	36	
	A5	4	100	255	16	125	51	
Arria V GX	A7	4	100	255	16	125	51	
Allia v GA	B1	4	100	344	16	125	69	
	B3	4	100	344	16	125	69	
	B5	4	100	465	16	125	93	
	B7	4	100	465	16	125	93	
	C3	4	100	178	16	125	36	
Arria V GT	C7	4	100	255	16	125	51	
Allia v Gi	D3	4	100	344	16	125	69	
	D7	4	100	465	16	125	93	
Arria V SX	В3	4	100	465	16	125	93	
Allia V SA	B5	4	100	465	16	125	93	
Arria V ST	D3	4	100	465	16	125	93	
	D5	4	100	465	16	125	93	

Related Information Configuration Files on page 1-83

(108) DCLK frequency of 100 MHz using external CLKUSR.
 (109) Maximum FPGA FPP bandwidth may exceed bandwidth available from some external storage or control logic.



Arria V GX, GT, SX, and ST Device Datasheet

Altera Corporation



Term	Definition
t _{FALL}	Signal high-to-low transition time (80–20%)
t _{INCCJ}	Cycle-to-cycle jitter tolerance on the PLL clock input
t _{OUTPJ_IO}	Period jitter on the GPIO driven by a PLL
t _{OUTPJ_DC}	Period jitter on the dedicated clock output driven by a PLL
t _{RISE}	Signal low-to-high transition time (20–80%)
Timing Unit Interval (TUI)	The timing budget allowed for skew, propagation delays, and the data sampling window. (TUI = $1/$ (Receiver Input Clock Frequency Multiplication Factor) = t_C/w)
V _{CM(DC)}	DC common mode input voltage.
V _{ICM}	Input common mode voltage—The common mode of the differential signal at the receiver.
V _{ID}	Input differential voltage swing—The difference in voltage between the positive and complementary conductors of a differential transmission at the receiver.
V _{DIF(AC)}	AC differential input voltage—Minimum AC input differential voltage required for switching.
V _{DIF(DC)}	DC differential input voltage— Minimum DC input differential voltage required for switching.
V _{IH}	Voltage input high—The minimum positive voltage applied to the input which is accepted by the device as a logic high.
V _{IH(AC)}	High-level AC input voltage
V _{IH(DC)}	High-level DC input voltage
V _{IL}	Voltage input low—The maximum positive voltage applied to the input which is accepted by the device as a logic low.
V _{IL(AC)}	Low-level AC input voltage
V _{IL(DC)}	Low-level DC input voltage
V _{OCM}	Output common mode voltage—The common mode of the differential signal at the transmitter.
V _{OD}	Output differential voltage swing—The difference in voltage between the positive and complementary conductors of a differential transmission line at the transmitter.
V _{SWING}	Differential input voltage
V _X	Input differential cross point voltage

Arria V GX, GT, SX, and ST Device Datasheet

Altera Corporation

Symbol	Description	Minimum ⁽¹¹⁸⁾	Typical	Maximum ⁽¹¹⁸⁾	Unit
		0.82	0.85	0.88	
V _{CCR_GXBL} ⁽¹²¹⁾	Receiver analog power supply (left side)	0.97	1.0	1.03	V
		1.03	1.05	1.07	
		0.82	0.85	0.88	
V _{CCR_GXBR} ⁽¹²¹⁾	Receiver analog power supply (right side)	0.97	1.0	1.03	V
		1.03	1.05	1.07	
		0.82	0.85	0.88	
V _{CCT_GXBL} ⁽¹²¹⁾	Transmitter analog power supply (left side)	0.97	1.0	1.03	V
		1.03	1.05	1.07	
		0.82	0.85	0.88	
V _{CCT_GXBR} ⁽¹²¹⁾	Transmitter analog power supply (right side)	0.97	1.0	1.03	V
		1.03	1.05	1.07	
V _{CCH_GXBL}	Transmitter output buffer power supply (left side)	1.425	1.5	1.575	V
V _{CCH_GXBR}	Transmitter output buffer power supply (right side)	1.425	1.5	1.575	V



⁽¹¹⁸⁾ This value describes the budget for the DC (static) power supply tolerance and does not include the dynamic tolerance requirements. Refer to the PDN tool for the additional budget for the dynamic tolerance requirements.

⁽¹²¹⁾ This supply must be connected to 1.0 V if the transceiver is configured at a data rate > 6.5 Gbps, and to 1.05 V if configured at a data rate > 10.3 Gbps when DFE is used. For data rate up to 6.5 Gbps, you can connect this supply to 0.85 V.

Transceiver Power Supply Requirements

Table 2-7: Transceiver Power Supply Voltage Requirements for Arria V GZ Devices

Conditions	VCCR_GXB and VCCT_GXB ⁽¹²²⁾	VCCA_GXB	VCCH_GXB	Unit
If BOTH of the following conditions are true:	1.05			
 Data rate > 10.3 Gbps. DFE is used. 				
If ANY of the following conditions are true ⁽¹²³⁾ :	1.0	3.0		
 ATX PLL is used. Data rate > 6.5Gbps. DFE (data rate ≤ 10.3 Gbps), AEQ, or EyeQ feature is used. 			1.5	V
If ALL of the following conditions are true:	0.85	2.5		
 ATX PLL is not used. Data rate ≤ 6.5Gbps. DFE, AEQ, and EyeQ are not used. 				

DC Characteristics

Supply Current

Standby current is the current drawn from the respective power rails used for power budgeting.

Use the Excel-based Early Power Estimator (EPE) to get supply current estimates for your design because these currents vary greatly with the resources you use.



Send Feedback

⁽¹²²⁾ If the VCCR_GXB and VCCT_GXB supplies are set to 1.0 V or 1.05 V, they cannot be shared with the VCC core supply. If the VCCR_GXB and VCCT_GXB are set to 0.85 V, they can be shared with the VCC core supply.

⁽¹²³⁾ Choose this power supply voltage requirement option if you plan to upgrade your design later with any of the listed conditions.

Bus Hold Specifications

Table 2-9: Bus Hold Parameters for Arria V GZ Devices

			V _{CCIO}										
Parameter	Symbol	Conditions	1.2	2 V	1.5	5 V	1.8	8 V	2.5	5 V	3.() V	Unit
			Min	Max	Min	Max	Min	Max	Min	Max	Min	Max	
Low sustaining current	I _{SUSL}	V _{IN} > V _{IL} (maximum)	22.5		25.0	_	30.0	_	50.0		70.0		μΑ
High sustaining current	I _{SUSH}	V _{IN} < V _{IH} (minimum)	-22.5		-25.0		-30.0	_	-50.0		-70.0	_	μΑ
Low overdrive current	I _{ODL}	$\begin{array}{c} 0\mathrm{V} < \mathrm{V_{IN}} < \\ \mathrm{V_{CCIO}} \end{array}$		120	_	160		200		300	_	500	μA
High overdrive current	I _{ODH}	$0V < V_{IN} < V_{CCIO}$		-120		-160		-200		-300	_	-500	μΑ
Bus-hold trip point	V _{TRIP}	_	0.45	0.95	0.50	1.00	0.68	1.07	0.70	1.70	0.80	2.00	V

On-Chip Termination (OCT) Specifications

If you enable OCT calibration, calibration is automatically performed at power-up for I/Os connected to the calibration block.

Table 2-10: OCT Calibration Accuracy Specifications for Arria V GZ Devices

OCT calibration accuracy is valid at the time of calibration only.





Symbol/Description	Conditions	Transceiver Speed Grade 2			Transceiver Speed Grade 3			Unit
Symbol/Description	Conditions	Min	Тур	Max	Min	Тур	Max	Onit
fixedclk clock frequency	PCIe Receiver Detect	-	100 or 125	_	_	100 or 125	—	MHz
Reconfiguration clock (mgmt_clk_ clk) frequency	—	100	_	125	100	_	125	MHz

Related Information

Arria V Device Overview

For more information about device ordering codes.

Receiver

Table 2-24: Receiver Specifications for Arria V GZ Devices

Speed grades shown refer to the PMA Speed Grade in the device ordering code. The maximum data rate could be restricted by the Core/PCS speed grade. Contact your Altera Sales Representative for the maximum data rate specifications in each speed grade combination offered. For more information about device ordering codes, refer to the *Arria V Device Overview*.

Symbol/Description	Conditions	Transceiver Speed Grade 2			Transceiver Speed Grade 3			Unit
Symbol/Description	Conditions	Min	Тур	Мах	Min	Тур	Мах	
Supported I/O Standards	1.4-V PCML, 1.5-V PCML, 2.5	-V PCML	LVPECL, a	and LVDS				
Data rate (Standard PCS) ⁽¹⁴³⁾ , ⁽¹⁴⁴⁾	—	600	_	9900	600	_	8800	Mbps
Data rate (10G PCS) (143), (144)	_	600		12500	600	_	10312.5	Mbps
Absolute V_{MAX} for a receiver pin $^{(145)}$	—	_		1.2	_	_	1.2	V
Absolute $\mathrm{V}_{\mathrm{MIN}}$ for a receiver pin	_	-0.4			-0.4	_		V

⁽¹⁴³⁾ The line data rate may be limited by PCS-FPGA interface speed grade.

⁽¹⁴⁴⁾ To support data rates lower than the minimum specification through oversampling, use the CDR in LTR mode only.



⁽¹⁴⁵⁾ The device cannot tolerate prolonged operation at this absolute maximum.

Symbol	Conditions		C3, I3I			C4, I4		Unit
Symbol	Conditions	Min	Тур	Мах	Min	Тур	Max	Unit
	SERDES factor J = 3 to 10 (182), (183)	(184)	_	1250	(184)	_	1050	Mbps
True Differential I/O Standards - f _{HSDR} (data rate)	SERDES factor $J \ge 4$ LVDS TX with DPA (185), (186), (187), (188)	(184)		1600	(184)		1250	Mbps
	SERDES factor J = 2, uses DDR Registers	(184)		(189)	(184)		(189)	Mbps
	SERDES factor J = 1, uses SDR Register	(184)	_	(189)	(184)		(189)	Mbps
Emulated Differential I/O Standards with Three External Output Resistor Networks - f _{HSDR} (data rate) (190)	SERDES factor J = 4 to 10 ⁽¹⁹¹⁾	(184)		840	(184)		840	Mbps

⁽¹⁸²⁾ If the receiver with DPA enabled and transmitter are using shared PLLs, the minimum data rate is 150 Mbps.

- ⁽¹⁸⁵⁾ Arria V GZ RX LVDS will need DPA. For Arria V GZ TX LVDS, the receiver side component must have DPA.
- Requires package skew compensation with PCB trace length. (186)
- (187)Do not mix single-ended I/O buffer within LVDS I/O bank.
- Chip-to-chip communication only with a maximum load of 5 pF. (188)
- ⁽¹⁸⁹⁾ The maximum ideal data rate is the SERDES factor (J) x the PLL maximum output frequency (fOUT) provided you can close the design timing and the signal integrity simulation is clean.
- ⁽¹⁹⁰⁾ You must calculate the leftover timing margin in the receiver by performing link timing closure analysis. You must consider the board skew margin, transmitter channel-to-channel skew, and receiver sampling margin to determine leftover timing margin.
- ⁽¹⁹¹⁾ When using True LVDS RX channels for emulated LVDS TX channel, only serialization factors 1 and 2 are supported.



⁽¹⁸³⁾ The F_{MAX} specification is based on the fast clock used for serial data. The interface F_{MAX} is also dependent on the parallel clock domain which is design dependent and requires timing analysis.

⁽¹⁸⁴⁾ The minimum specification depends on the clock source (for example, the PLL and clock pin) and the clock routing resource (global, regional, or local) that you use. The I/O differential buffer and input register do not have a minimum toggle rate.

2-50 Soft CDR Mode High-Speed I/O Specifications

Standard	Training Pattern	Number of Data Transitions in One Repetition of the Training Pattern	Number of Repetitions per 256 Data Transitions (201)	Maximum
Parallel Rapid I/O	00001111	2	128	640 data transitions
r araner Rapid 1/0	10010000	4	64	640 data transitions
Miscellaneous	10101010	8	32	640 data transitions
	01010101	8	32	640 data transitions

Soft CDR Mode High-Speed I/O Specifications

Table 2-44: High-Speed I/O Specifications for Arria V GZ Devices

When J = 3 to 10, use the serializer/deserializer (SERDES) block.

When J = 1 or 2, bypass the SERDES block.

Symbol	Conditions	C3, I3L			C4, I4			Unit
		Min	Тур	Мах	Min	Тур	Мах	Onit
Soft-CDR ppm tolerance	—			300		—	300	± ppm





⁽²⁰¹⁾ This is the number of repetitions for the stated training pattern to achieve the 256 data transitions.

Table 2-60: PS Timing Parameters for Arria V GZ Devices

Symbol	Parameter	Minimum	Maximum	Unit
t _{CF2CD}	nCONFIG low to CONF_DONE low	—	600	ns
t _{CF2ST0}	nCONFIG low to nSTATUS low	_	600	ns
t _{CFG}	nCONFIG low pulse width	2		μs
t _{STATUS}	nSTATUS low pulse width	268	1,506 (217)	μs
t _{CF2ST1}	nCONFIG high to nSTATUS high	_	1,506 (218)	μs
t _{CF2CK} (219)	nCONFIG high to first rising edge on DCLK	1,506	_	μs
t _{ST2CK} (219)	nSTATUS high to first rising edge of DCLK	2		μs
t _{DSU}	DATA[] setup time before rising edge on DCLK	5.5		ns
t _{DH}	DATA[] hold time after rising edge on DCLK	0	_	ns
t _{CH}	DCLK high time	$0.45 imes 1/f_{MAX}$		s
t _{CL}	DCLK low time	$0.45 imes 1/f_{MAX}$	—	S
t _{CLK}	DCLK period	1/f _{MAX}		s
f _{MAX}	DCLK frequency	_	125	MHz
t _{CD2UM}	CONF_DONE high to user mode ⁽²²⁰⁾	175	437	μs
t _{CD2CU}	CONF_DONE high to CLKUSR enabled	$4 \times \text{maximum DCLK}$ period		
t _{CD2UMC}	CONF_DONE high to user mode with CLKUSR option on	t_{CD2CU} + (8576 × CLKUSR period) (221)	_	

⁽²¹⁷⁾ This value is applicable if you do not delay configuration by extending the nCONFIG or nSTATUS low pulse width.



⁽²¹⁸⁾ This value is applicable if you do not delay configuration by externally holding the nSTATUS low.

⁽²¹⁹⁾ If nSTATUS is monitored, follow the t_{ST2CK} specification. If nSTATUS is not monitored, follow the t_{CF2CK} specification.

⁽²²⁰⁾ The minimum and maximum numbers apply only if you choose the internal oscillator as the clock source for initializing the device.

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Table 2-62: Uncompressed .rbf Sizes for Arria V GZ Devices

Variant	Member Code	Configuration .rbf Size (bits)	IOCSR .rbf Size (bits) (223)	
Arria V GZ	E1	137,598,880	562,208	
	E3	137,598,880	562,208	
	E5	213,798,880	561,760	
	E7	213,798,880	561,760	

Table 2-63: Minimum Configuration Time Estimation for Arria V GZ Devices

		Active Serial ⁽²²⁴⁾			Fast Passive Parallel (225)		
Variant Member Code	Width	DCLK (MHz)	Min Config Time (ms)	Width	DCLK (MHz)	Min Config Time (ms)	
	E1	4	100	344	32	100	43
Arria V GZ	E3	4	100	344	32	100	43
	E5	4	100	534	32	100	67
	E7	4	100	534	32	100	67

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Table 2-64: Remote System Upgrade Circuitry Timing Specifications

Parameter	Minimum	Maximum	Unit
t _{RU_nCONFIG} ⁽²²⁶⁾	250	—	ns
t _{RU_nRSTIMER} ⁽²²⁷⁾	250	_	ns

⁽²²³⁾ The IOCSR **.rbf** size is specifically for the Configuration via Protocol (CvP) feature.

⁽²²⁴⁾ DCLK frequency of 100 MHz using external CLKUSR.

(225) Max FPGA FPP bandwidth may exceed bandwidth available from some external storage or control logic.



Programmable IOE Delay

Fast Model Slow Model Available Parameter (228) Min Offset (229) Unit Settings Industrial Commercial C3 C4 I3L 14 D1 64 0 0.464 0.493 0.924 1.011 0.921 1.006 ns 0 D2 32 0.230 0.244 0.459 0.503 0.456 0.500 ns D3 8 0 1.699 2.992 3.192 1.587 3.047 3.257 ns 0 D4 64 0.464 0.492 0.924 1.011 0.920 1.006 ns D5 64 0 0.464 0.493 0.924 1.011 0.921 1.006 ns 0.499 D6 32 0 0.244 0.503 0.229 0.458 0.456 ns

Table 2-66: IOE Programmable Delay for Arria V GZ Devices

Programmable Output Buffer Delay

Table 2-67: Programmable Output Buffer Delay for Arria V GZ Devices

You can set the programmable output buffer delay in the Quartus II software by setting the **Output Buffer Delay Control** assignment to either positive, negative, or both edges, with the specific values stated here (in ps) for the **Output Buffer Delay** assignment.

Symbol	Parameter	Typical	Unit
		0 (default)	ps
	Rising and/or falling edge delay	50	ps
D _{outbuf}	Rising and/or failing edge delay	100	ps
		150	ps

⁽²²⁸⁾ You can set this value in the Quartus II software by selecting **D1**, **D2**, **D3**, **D4**, **D5**, and **D6** in the **Assignment Name** column of **Assignment Editor**.





⁽²²⁹⁾ Minimum offset does not include the intrinsic delay.

Date	Version	Changes
July 2014	3.8	 Updated Table 21. Updated Table 22 V_{OCM} (DC Coupled) condition. Updated the DCLK note to Figure 6, Figure 7, and Figure 9. Added note to Table 5 and Table 6. Added the DCLK specification to Table 50. Added note to Table 51. Updated the list of parameters in Table 53.
February 2014	3.7	Updated Table 28.
December 2013	3.6	 Updated Table 2, Table 13, Table 18, Table 19, Table 22, Table 30, Table 33, Table 37, Table 38, Table 45, Table 46, Table 47, Table 56, Table 49. Updated "PLL Specifications".
August 2013	3.5	Updated Table 28.
August 2013	3.4	 Removed Preliminary tags for Table 2, Table 4, Table 5, Table 14, Table 27, Table 28, Table 29, Table 31, Table 32, Table 43, Table 45, Table 46, Table 47, Table 48, Table 49, Table 50, and Table 54. Updated Table 2 and Table 28.
June 2013	3.3	Updated Table 23, Table 28, Table 51, and Table 55.
May 2013	3.2	 Added Table 23. Updated Table 5, Table 22, Table 26, and Table 57. Updated Figure 6, Figure 7, Figure 8, and Figure 9.
March 2013	3.1	 Updated Table 2, Table 6, Table 7, Table 8, Table 19, Table 22, Table 26, Table 29, Table 52. Updated "Maximum Allowed Overshoot and Undershoot Voltage".
December 2012	3.0	Initial release.

